

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

SCP40N03S-C uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications

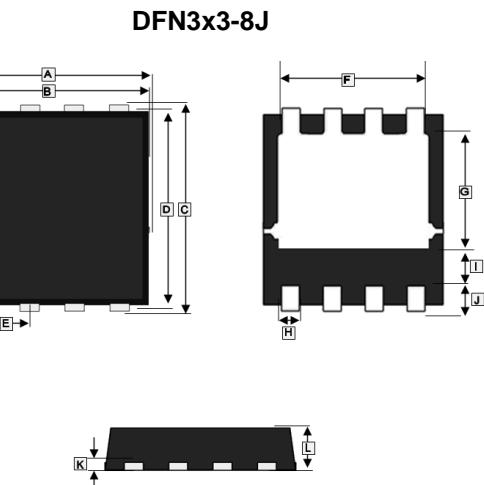
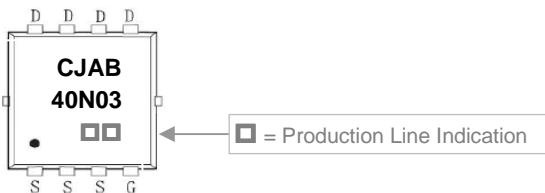
FEATURES

- Battery switch
- Load switch
- High density cell design for ultra low $R_{DS(ON)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAs
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

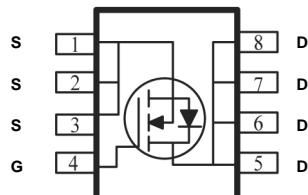
APPLICATIONS

- SMPS and general purpose applications
- Hard switched and high frequency circuits
- Uninterruptible Power Supply

MARKING



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	3.2	3.4	G	1.78	1.98
B	3	3.2	H	0.25	0.35
C	3.25	3.45	I	0.35TYP.	
D	3	3.2	J	0.6TYP.	
E	0.65BSC.		K	0.1	0.25
F	2.39	2.59	L	0.7	0.8



PACKAGE INFORMATION

Package	MPQ	Leader Size
DFN3x3-8J	5K	13 inch

ORDER INFORMATION

Part Number	Type
SCP40N03S-C	Lead (Pb)-free and Halogen-free

ABSOLUTE MAXIMUM RATINGS

 ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	I_D	40	A
Pulsed Drain Current	I_{DM}	160	A
Single Pulse Avalanche Energy ²	E_{AS}	270	mJ
Power Dissipation	$T_A=25^\circ\text{C}$	3	W
		34.7	
Thermal Resistance from Junction to Ambient ¹	$R_{\theta JA}$	41.67	°C/W
Thermal Resistance from Junction to Case ¹	$R_{\theta JC}$	3.6	
Lead Temperature for Soldering Purposes @ 1/8" from case for 10s	T_L	260	°C
Junction and Storage Temperature Range	T_J, T_{STG}	150, -55~150	°C

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	30	-	-	V	$V_{GS}=0$, $I_D=250\mu A$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=24V$, $V_{GS}=0V$
Gate-Body Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{DS}=0V$, $V_{GS}= \pm 20V$
Gate-Threshold Voltage	$V_{GS(th)}$	1	1.5	2.5	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
Static Drain-Source On-Resistance ³	$R_{DS(ON)}$	-	4.5	6.5	mΩ	$V_{GS}=10V$, $I_D=20A$
		-	7.2	10.5		$V_{GS}=4.5V$, $I_D=20A$
Forward Transconductance	g_{fs}	-	24	-	S	$V_{DS}=10V$, $I_D=20A$
Total Gate Charge	Q_g	-	50	-	nC	$V_{DS}=25V$
Gate-Source Charge	Q_{gs}	-	3	-		$V_{GS}=10V$
Gate-Drain Charge	Q_{gd}	-	18	-		$I_D=10A$
Turn-on Delay Time	$T_{d(on)}$	-	12	-	nS	$V_{DS}=15V$
Rise Time	T_r	-	36	-		$I_D=10A$
Turn-off Delay Time	$T_{d(off)}$	-	49	-		$V_{GS}=10V$
Fall Time	T_f	-	12	-		$R_G=3\Omega$
Input Capacitance	C_{iss}	-	2000	-	pF	$V_{DS}=25V$
Output Capacitance	C_{oss}	-	228	-		$V_{GS}=0V$
Reverse Transfer Capacitance	C_{rss}	-	155	-		f=1MHz
Drain-Source Diode						
Diode Forward Voltage ³	V_{SD}	-	-	1.2	V	$V_{GS}=0V$, $I_S=20A$
Continuous Source Current ¹	I_S	-	-	40	A	
Pulsed Source Current	I_{SM}	-	-	160	A	

Notes:

1. Mounted on a 25.4mm × 25.4mm × 0.8mm glass epoxy board.
2. Test condition: $V_{DD}=15V$, $L=0.1mH$, $R_G=25\Omega$, Starting $T_J=25^\circ C$.
3. Pulse Test: Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

CHARACTERISTICS CURVE

